## Search Notes



Application/Control No.

10811214

Reexamination LIN, JYUN-NAIH

Applicant(s)/Patent Under

Examiner

Moutaouakil, Mounir

Art Unit

2616

## **SEARCHED**

Class	Subclass	Date	Examiner
370	392.54	6/30/2007	MM
370	392.52	6/30/2007	MM
370	351	6/30/2007	MM
370	473	6/30/2007	MM
370	474	6/30/2007	MM
370	475	6/30/2007	MM
370	476	6/30/2007	MM
379	219	6/30/2007	MM
379	220	6/30/2007	MM
379	242	6/30/2007	MM
709	235	6/30/2007	MM
709	236	6/30/2007	MM
709	238	6/30/2007	MM
709	242	6/30/2007	MM
709	245	6/30/2007	MM

## **SEARCH NOTES**

Search Notes	Date	Examiner
Consulted with Hassan Kizou (SPE)		MM
IEEE Xplore		MM
WIPO	·	MM
Inventorship search		MM
EAST		MM

## **INTERFERENCE SEARCH**

Class Subclass Date	Examiner